

U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE  INFORMATION DISCLOSURE STATEMENT BY APPLICANT  (use several sheets if necessary)  (PTO-1449)	PATENT DOCKET NO. 176/60930		SERIAL NO. 09/759,913
	APPLICANT David P. Biss, Thomas G. Brown, and Kathleen S. Youngworth		
	FILING DATE January 12, 2001		GROUP ART UNIT 2873

## U.S. PATENT DOCUMENTS

EXAMINER INITIAL	DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPRO- PRIATE

## FOREIGN PATENT DOCUMENTS

DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRAN- SLATION IF APPRO- PRIATE

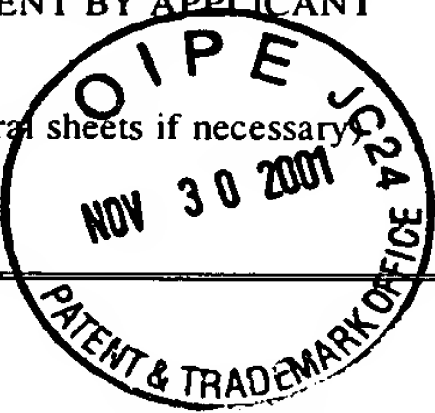
## OTHER DOCUMENTS (including Author, Title, Date, Pertinent Pages, Etc.)

RDS	1	R. D. Allen et al., "The Zeiss-Nomarski Differential Interference Equipment For Transmitted Light Microscopy,"
		Z. wiss. Mikroskopie, 69:193-221 (1969).
RDS	2	E. Slayter, "The Interference Microscope," <u>Optical Methods in Biology</u> , Chapter 14., New York:John Wiley & Sons,
		page 303 (1970).
RDS	3	E. Slayter, "The Polarizing Microscope," <u>Optical Methods in Biology</u> , Chapter 15, New York:John Wiley & Sons,
		pp. 318-340 (1970).
RDS	4	D. Pohl, "Operation Of A Ruby Laser In The Purely Transverse Electric Mode TE <sub>01</sub> ," <u>Appl. Phys. Lett.</u> , 20:266-267
		(1972).
RDS	5	J. J. Wynne, "Generation Of the Rotationally Symmetric TE <sub>01</sub> and TM <sub>01</sub> Modes From A Wavelength-Tunable Laser,"
		<u>IEEE J. Quant. Elec.</u> , QE-10:125-127 (1974).
RDS	6	M. E. Marhic et al., "Low-Order TE <sub>0q</sub> Operation Of A CO <sub>2</sub> Laser For Transmission Through Circular Metallic
		Waveguides," <u>Appl. Phys. Lett.</u> , 38:743-745 (1981).
RDS	7	R. Yamaguchi et al., "Liquid-Crystal Polarizers With Axially Symmetrical Properties," <u>Japanese Journal of Applied</u>
		<u>Physics</u> , 28:1730-1731 (1989).
EXAMINER		DATE CONSIDERED
RDS		12/28/03
EXAMINER: Initial if citation considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.		

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PATENT AND TRADEMARK OFFICE

INFORMATION DISCLOSURE  
STATEMENT BY APPLICANT

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ATTY. DOCKET NO.

176/60930

SERIAL NO.

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APPLICANT

David P. Biss, Thomas G. Brown, and Kathleen S. Youngworth

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GROUP ART UNIT

2873

U.S. PATENT DOCUMENTS

EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPRO- PRIATE

FOREIGN PATENT DOCUMENTS

		DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANS- LATION IF APPRO- PRIATE

OTHER DOCUMENTS (including Author, Title, Date, Pertinent Pages, Etc.)

RNS		8	C. J. Cogswell et al., "Confocal Brightfield Imaging Techniques," T. Wilson, <u>Confocal Microscopy</u> , London: Academic Press Limited, Chapter 8, page 229 (1990).
RNS		9	S. C. Tidwell et al., "Generating Radially Polarized Beams Interferometrically," <u>Applied Optics</u> , 29:2234-2239 (1990).
RNS		10	T. Erdogan et al., "Circularly Symmetrical Operation Of A Concentric-Circle-Grating, Surface-Emitting, AlGaAs/GaAs Quantum-Well Semiconductor-Laser," <u>Appl. Phys. Lett.</u> , 60:1921-1923 (1992).
RNS		11	E. G. Churin et al., "Polarization Configurations With Singular Point Formed By Computer-Generated Holograms," <u>Optics Communications</u> , 99:13-17 (1993).
RNS		12	S. C. Tidwell et al., "Efficient Radially Polarized Laser Beam Generation With A Double Interferometer," <u>Applied Optics</u> , 32:5222-5229 (1993).
RNS		13	R. H. Jordan et al., "Free-Space Azimuthal Paraxial Wave Equation: The Azimuthal Bessel-Gauss Beam Solution," <u>Optics Letters</u> , 19:427-429 (1994).
RNS		14	D. G. Hall, "Vector-Beam Solutions Of Maxwell's Wave Equation," <u>Optics Letters</u> , 21:9-11 (1996).
RNS		15	P. L. Greene et al., "Diffraction Characteristics Of The Azimuthal Bessel-Gauss Beam," <u>J. Opt. Soc. Am. A</u> , 13:962-966 (1996).
RNS		16	M. Stalder et al., "Linearly Polarized Light With Axial Symmetry Generated By Liquid-Crystal Polarization Converters," <u>Optics Letters</u> , 21:1948-1950 (1996).

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